

**Notice of References Cited**

Application/Control No.

09/917,637

Applicant(s)/Patent Under  
Reexamination  
HATANO ET AL.

Examiner

Patrick J. Lee

Art Unit

2878

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,528,780	03-2003	Mitsuoka et al.	250/216
	B	US-6,185,051	02-2001	Chen et al.	359/709
	C	US-6,493,156	12-2002	Oh et al.	359/742
	D	US-6,552,852	04-2003	Hill	359/618
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.